Application/Control No. Applicant(s)/Patent Under Reexamination 09/422,528 LEUNG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Christian L. Fronda 1652 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-US-K US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s

	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Van Dien et al. Appl Environ Microbiol. 1997 May;63(5):1689-95.
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NON-PATENT DOCUMENTS

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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